

Docket No. A34263

# INFORMATION CITED BY APPLICANT(S) THAT MAY BE MATERIAL TO THE PROSECUTION OF THE SUBJECT APPLICATION

Applicants: Fraser Keith Mc.Neil-Watson et al

Attorney Docket No.: A34263

Serial No.: 09/843,339

**Group Art Unit:** 

1743

Filed:

04/26/2001

Examiner:

Sharon Latimer

Title:

Mobility and Effects arising from Surface Charge

#### **U.S PATENT DOCUMENTS**

Examiner Initial	Document		Date	Name	Class	Sub-Class
	ID	No	[mm.dd.yy]			
læ	US1	US4 097 153A	06/27/78	DeRemigis, Joseph		
	US2					
	US3					
	US4					
	US5					
	US6					
	US7					
	US8					

#### **FOREIGN PATENT DOCUMENTS**

Examiner	Document		Date	Ctry	Name	Class	Sub-	T
Initial	ID	No	[mm.dd.yy]			Olass	Class	Trans
læ	F1	WO9394363A	03/04/93	AU	Colloical Dynamics Pty Ltd and Matic Applied Sciences Inc (US)			
læ,	F2	WO8802482A	04/07/88	AU	O'Brien, Richard Wyndham	<del> </del>		_
	F3							
	F4			1		<del> </del>		<del>                                     </del>
	F5				<del></del>			<del></del>
	F6					RE	CEIV	مات
	F7			•		NO	<b>/ 2.7</b> 200	
	F8						471	

## OTHER INFORMATION

(Including Author, title, Date, Patent Pages, etc.)

CONNAH, M.T.: "Recent Development in the Measurement of Zeta-potential" - ANALYTICAL PROCEEDINGS vol. 30, No. 12, 1993, pages 496-497, XP008009347 - gb

**NOTES** 

Lp. Ch 1/16/06

<sup>\*</sup>Examiner: Initial If reference considered whether or not citation is in conformance with M.P.E.P. §609; draw line through citation if not in conformance and not considered. Include copy of this form with the next communication to applicant.

Form PTO-1449 U.S. Department of Commerce (REV. 2-82) Patent and Trademark Office	Atty. Docket No. 072819.0128	Serial No. 09/843,339			
INFORMATION DISCLOSURE STATEMENT BY APPLICANT	Applicant McNeil-Watson et al.				
(Use several sheets if necessary)	Filing Date April 26, 2001	Group Art Unit 1713			
	Examiner Ling Siu Choi				

### **U.S. PATENT DOCUMENTS**

Exam. Initial.	No.	Document No.	Issue/PublicationDate	Applicant(s)
les	l.	4,351,709	09/28/1982	Goetz
lie	2.	4,101,220	07/18/1978	Bean et al.

FOREIGN PATENT DOCUMENTS							
Exam Initial	No.	Document No.	Date .	Country	Class	Subclass	Translation Yes No
lu	3.	WO 93/04363	03/04/1993	WO			

NY02:566286.1			
Examiner	Date Considered	1/2/07	

<sup>\*</sup> Examiner: Initial citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.